## Features

- No External Components Except PIN Diode
- Supply-voltage Range: 4.5V to 5.5V
- Automatic Sensitivity Adaptation (AGC)
- Automatic Strong Signal Adaptation (ATC)
- Enhanced Immunity Against Ambient Light Disturbances
- Available for Carrier Frequencies between 33 kHz to 40 kHz; Adjusted by Zener Diode Fusing
- TTL and CMOS Compatible
- Suitable Minimum Burst Length  $\geq$  10 Pulses/Burst

## Applications

- Audio Video Applications
- Home Appliances
- Remote Control Equipment

## 1. Description

The IC ATA2525 is a complete IR receiver for data communication that was developed and optimized for use in carrier-frequency-modulated transmission applications. Its function can be described using the block diagram (see Figure 1-1 on page 2). The input stage meets two main functions. First, it provides a suitable bias voltage for the PIN diode. Secondly, the pulsed photo-current signals are transformed into a voltage by a special circuit which is optimized for low-noise applications. After amplification by a **C**ontrolled **G**ain **A**mplifier (CGA), the signals have to pass a tuned integrated narrow bandpass filter with a center frequency  $f_0$  which is equivalent to the chosen carrier frequency of the input signal. The demodulator is used to convert the input burst signal into a digital envelope output pulse and to evaluate the signal information quality, i.e., unwanted pulses will be suppressed at the output pin. All this is done by means of an integrated dynamic feedback circuit which varies the gain as a function of the present environmental condition (ambient light, modulated lamps etc.). Other special features are used to adapt to the current application to secure best transmission quality. The ATA2525 operates in a supply-voltage range of 4.5V to 5.5V.



IR Receiver ASSP

# ATA2525

# Preliminary

Rev. 4854B-AUTO-05/05





Figure 1-1. Block Diagram



## 2. Pin Configuration

## Figure 2-1. Pinning TSSOP8

vs⊏	10	8	
NC 🗆	2	7	D NC
OUT 🗆	3	6	GND 🗆
NC 🗆	4	5	D IN
			1

### Table 2-1.Pin Description

Pin	Symbol	Function
1	VS	Supply voltage
2	NC	Not connected
3	OUT	Data output
4	NC	Not connected
5	IN	Input PIN diode
6	GND	Ground
7	NC	Not connected
8	NC	Not connected

# 3. Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

	-		-
Parameters	Symbol	Value	Unit
Supply voltage	V <sub>S</sub>	-0.3 to +6	V
Supply current	I <sub>S</sub>	3	mA
Input voltage	V <sub>IN</sub>	–0.3 to $V_{\rm S}$	V
Input DC current at $V_S = 5V$	I <sub>IN</sub>	0.75	mA
Output voltage	Vo	–0.3 to $V_{\rm S}$	V
Output current	Ι <sub>ο</sub>	10	mA
Operating temperature	T <sub>amb</sub>	-25 to +85	°C
Storage temperature	T <sub>stg</sub>	-40 to +125	°C
Power dissipation at $T_{amb} = 25^{\circ}C$	P <sub>tot</sub>	30	mW

## 4. Thermal Resistance

Parameter	Symbol	Value	Unit
Junction ambient TSSOP8	R <sub>thJA</sub>	110	K/W

# 5. Electrical Characteristics

 $T_{amb} = -25^{\circ}C$  to +85°C,  $V_{S} = 4.5V$  to 5.5V unless otherwise specified.

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
1	Supply								
1.1	Supply-voltage range		1	Vs	4.5	5	5.5	V	С
1.2	Supply current	$I_{IN} = 0$	1	ا <sub>s</sub>	0.8	1.1	1.4	mA	В
2	Output	·							
2.1	Internal pull-up resistor	T <sub>amb</sub> = 25°C; see Figure 8-7 on page 8	1,3	R <sub>PU</sub>		40		kΩ	А
2.2	Output voltage low	$I_L = 2 \text{ mA}; \text{ see}$ Figure 8-7 on page 8	3,6	V <sub>OL</sub>			250	mV	В
2.3	Output voltage high		3,1	V <sub>OH</sub>	$V_{S} - 0.25$		Vs	V	В
2.4	Output current clamping	R <sub>2</sub> = 0; see Figure 8-7 on page 8	3,6	I <sub>OCL</sub>		8		mA	В
3	3 Input								
3.1	Input DC current	V <sub>IN</sub> = 0; see Figure 8-7 on page 8	5	I <sub>IN_DCMAX</sub>	-85			μA	С
3.2	Input DC current; Figure 8-1 on page 5	$V_{IN} = 0; V_s = 5V,$ $T_{amb} = 25^{\circ}C$	5	I <sub>IN_DCMAX</sub>	-530	-960		μA	В

\*) Type means: A =100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

BER = Bit Error Rate; e.g., BER = 5% means that with P = 20 at the input pin 19...21 pulses can appear at the pin OUT
After transformation of input current into voltage

AIMEL



## 5. Electrical Characteristics (Continued)

 $T_{amb}$  = –25°C to +85°C,  $V_S$  = 4.5V to 5.5V unless otherwise specified.

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Тур.	Max.	Unit	Type*
3.3	Minimum detection threshold current; Figure 8-2 on page 5	Test signal: see Figure 8-6 on page 7 $V_S = 5V$ , $T_{amb} = 25^{\circ}C$ , $I_{N\_DC} = 1 \mu A$ ; square pp, burst N = 16, $f = f_0$ ; $t_{PER} = 10$ ms, Figure 8-6 on page 7; BER = 50 <sup>(1)</sup>	3	I <sub>Eemin</sub>		-520		рА	в
3.4	Minimum detection threshold current with AC current disturbance IIN_AC100 = 3 µA at 100 Hz	Test signal: see Figure 8-6 on page 7 $V_S = 5V$ , $T_{amb} = 25^{\circ}C$ , $I_{IN_DC} = 1 \mu A$ , square pp, burst N = 16, $f = f_0$ ; $t_{PER} = 10$ ms, Figure 8-6 on page 7; BER = 50% <sup>(1)</sup>	3	I <sub>Eemin</sub>		-800		pА	С
3.5	Maximum detection threshold current with V <sub>IN</sub> > 0V	Test signal: see Figure 8-6 on page 7 $V_S = 5V$ , $T_{amb} = 25^{\circ}C$ , $I_{IN_DC} = 1 \mu A$ ; square pp, burst N = 16, $f = f_0$ ; $t_{PER} = 10$ ms, Figure 8-6 on page 7; BER = 5% <sup>(1)</sup>	3	I <sub>Eemax</sub>	-400			μA	D
4	Controlled Amplifier a	nd Filter			1			1	
4.1	Maximum value of variable gain (CGA)			G <sub>VARMAX</sub>		51		dB	D
4.2	Minimum value of variable gain (CGA)			G <sub>VARMIN</sub>		-5		dB	D
4.3	Total internal amplification <sup>(2)</sup>			G <sub>MAX</sub>		71		dB	D
4.4	Center frequency fusing accuracy of bandpass	$V_{S} = 5V, T_{amb} = 25^{\circ}C$		f <sub>0_FUSE</sub>	-3	f <sub>o</sub>	+3	%	А
4.5	Overall accuracy center frequency of bandpass			f <sub>0</sub>	-6.7	f <sub>0</sub>	+4.1	%	С
4.6	BPF bandwidth	-3 dB; f <sub>0</sub> = 38 kHz; see Figure 8-4 on page 6		В		3.5		kHz	В

\*) Type means: A =100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

Notes: 1. BER = Bit Error Rate; e.g., BER = 5% means that with P = 20 at the input pin 19...21 pulses can appear at the pin OUT

2. After transformation of input current into voltage

## 6. ESD

All pins  $\Rightarrow$  4000V HBM; 400V MM, MIL-STD-883C, Method 3015.7 LU 100 mA; Jedec 17/78

## 7. Reliability

Electrical qualification (1000h at 150°C) in molded SO8 plastic package

## 8. Typical Electrical Curves at T<sub>amb</sub> = 25°C

Figure 8-1.  $V_{IN}$  versus  $I_{IN\_DC}$ ,  $V_S = 5V$ 



**Figure 8-2.**  $I_{\text{Eemin}}$  versus  $I_{\text{IN}_{\text{DC}}}$ ,  $V_{\text{S}} = 5V$ 







Figure 8-3. Data Transmission Rate,  $V_S = 5V$ 







 $Q=f_0/\Delta f;$   $\Delta f=-3~dB$  values. Example: Q=1/(1.047-0.954)=11















Figure 8-7. Application Circuit



## 9. Chip Dimensions



Figure 9-1. Chip Size in µm

Note: Pad coordinates are for lower left corner of the pad in µm from the origin 0,0

Dimensions	Length inclusive scribe	1.04 mm
	Width inclusive scribe	1.11 mm
	Thickness	290 µ ±5%
	Pads	$80~\mu\times80~\mu$
	Fusing pads	$60~\mu\times~60~\mu$
Pad metallurgy	Material	AlCu/AlSiTi <sup>(1)</sup>
	Thickness	0.8 µm
Finish	Material	$\mathrm{Si_3N_4}/\mathrm{SiO_2}^{(1)}$
	Thickness	0.7/0.3 µm

Note: 1. Value depends on manufacture location.





## **10. Ordering Information**

Extended Type Number	D <sup>(3)</sup>	Туре
ATA2525P1.xx <sup>(1)</sup> -yyy <sup>(2)</sup>	1493	Standard type: high data rate
ATA2525P3.xx <sup>(1)</sup> -yyy <sup>(2)</sup>	980	Lamp type: enhanced suppression of disturbances, secure data transmission
ATA2525P5.xx <sup>(1)</sup> -yyy <sup>(2)</sup>	730	Noise type: best suppression of disturbances, low data rate

Notes: 1. xx means the used carrier frequency value (33, 36, 38 or 40 kHz)

 yyy means kind of packaging: DDW --> unsawn wafers in box 6AQ --> (only on request, TSSOP8 taped and reeled)

3. Maximum data transmission rate up to bits/s with  $f_0 = 40$  kHz,  $V_S = 5V$  (see Figure 8-2 on page 5)

## 11. Pad Layout





Table 11-1. Pin Description

Symbol	Function
OUT	Data output
VS	Supply voltage
GND	GND
IN	Input pin diode
Zapping	f <sub>0</sub> adjust
Versioning	type adjust



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